

<b>Notice of References Cited</b>	Application/Control No. 09/760,327	Applicant(s)/Patent Under Reexamination CHILOYAN ET AL.	
	Examiner Thomas Duong	Art Unit 2145	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0067504	06-2002	Salgado et al.	358/1.15
	B	US-6,009,480 A	12-1999	Pleso, Mark F.	710/8
	C	US-6,148,346 A	11-2000	Hanson, Gordon L.	719/321
	D	US-5,870,610 A	02-1999	Beyda, William J.	717/173
	E	US-5,664,195 A	09-1997	Chatterji, Sanjoy	717/178
	F	US-6,813,670 B1	11-2004	Yao et al.	710/302
	G	US-6,754,722 B2	06-2004	Herzi, Dirie	710/8
	H	US-2003/0065773 A1	04-2003	Aiba et al.	709/224
	I	US-6,529,946 B2	03-2003	Yokono et al.	709/217
	J	US-6,167,567 A	12-2000	Chiles et al.	717/173
	K	US-5,845,077 A	12-1998	Fawcett, Philip E.	709/221
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
	W	
	X	

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